

AS5162

12-Bit Magnetic Angle Position Sensor

General Description

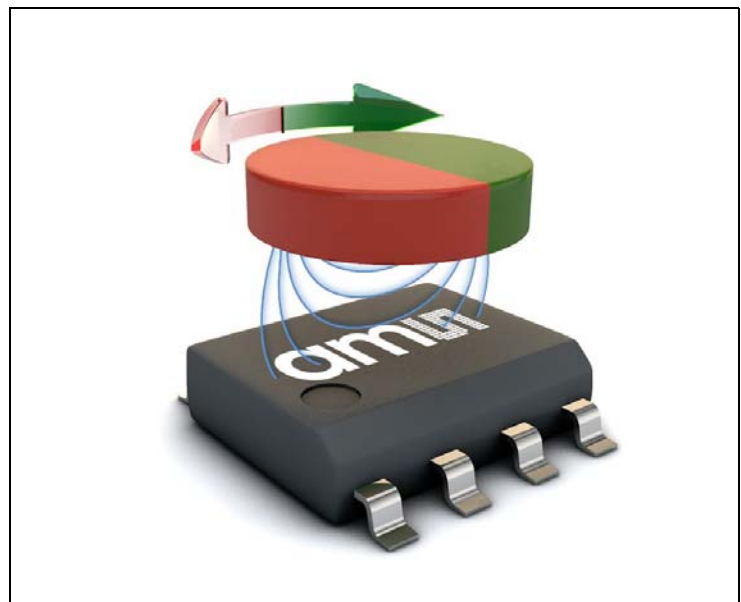
The AS5162 is a contactless magnetic angle position sensor for accurate angular measurement over a full turn of 360°. A sub range can be programmed to achieve the best resolution for the application. It is a system-on-chip, combining integrated Hall elements, analog front end, digital signal processing and best in class automotive protection features in a single device.

To measure the angle, only a simple two-pole magnet, rotating over the center of the chip, is required. The magnet may be placed above or below the IC.

The absolute angle measurement provides instant indication of the magnet's angular position with a resolution of $0.022^\circ = 16384$ positions per revolution. According to this resolution the adjustment of the application specific mechanical positions are possible. The angular output data is available over a 12 bit ratiometric analog output.

The AS5162 operates at a supply voltage of 5V and the supply and output pins are protected against overvoltage up to +20V. In addition the supply pins are protected against reverse polarity up to -20V.

Figure 1:
Typical Arrangement of AS5162 and Magnet



Ordering Information and Content Guide appear at end of datasheet.

Key Benefits & Features

The benefits and features of AS5162, 12-Bit Magnetic Angle Position Sensor are listed below:

Figure 2:
Added Value of Using AS5162

| Benefits | Features |
|--|--|
| <ul style="list-style-type: none"> • Great flexibility on angular excursion | <ul style="list-style-type: none"> • 360° contactless high resolution angular position sensing |
| <ul style="list-style-type: none"> • Simple programming | <ul style="list-style-type: none"> • User programmable start and end point of the application region • Saw tooth mode 1-4 slopes per revolution • Clamping levels • Transition point |
| <ul style="list-style-type: none"> • Failure diagnostics | <ul style="list-style-type: none"> • Broken GND and VDD detection for all external load cases |
| <ul style="list-style-type: none"> • High-Resolution output signal | <ul style="list-style-type: none"> • Analog output ratiometric to VDD |
| <ul style="list-style-type: none"> • Ideal for applications in harsh environments due to contactless position sensing | <ul style="list-style-type: none"> • Wide temperature range: - 40°C to 150°C |

Applications

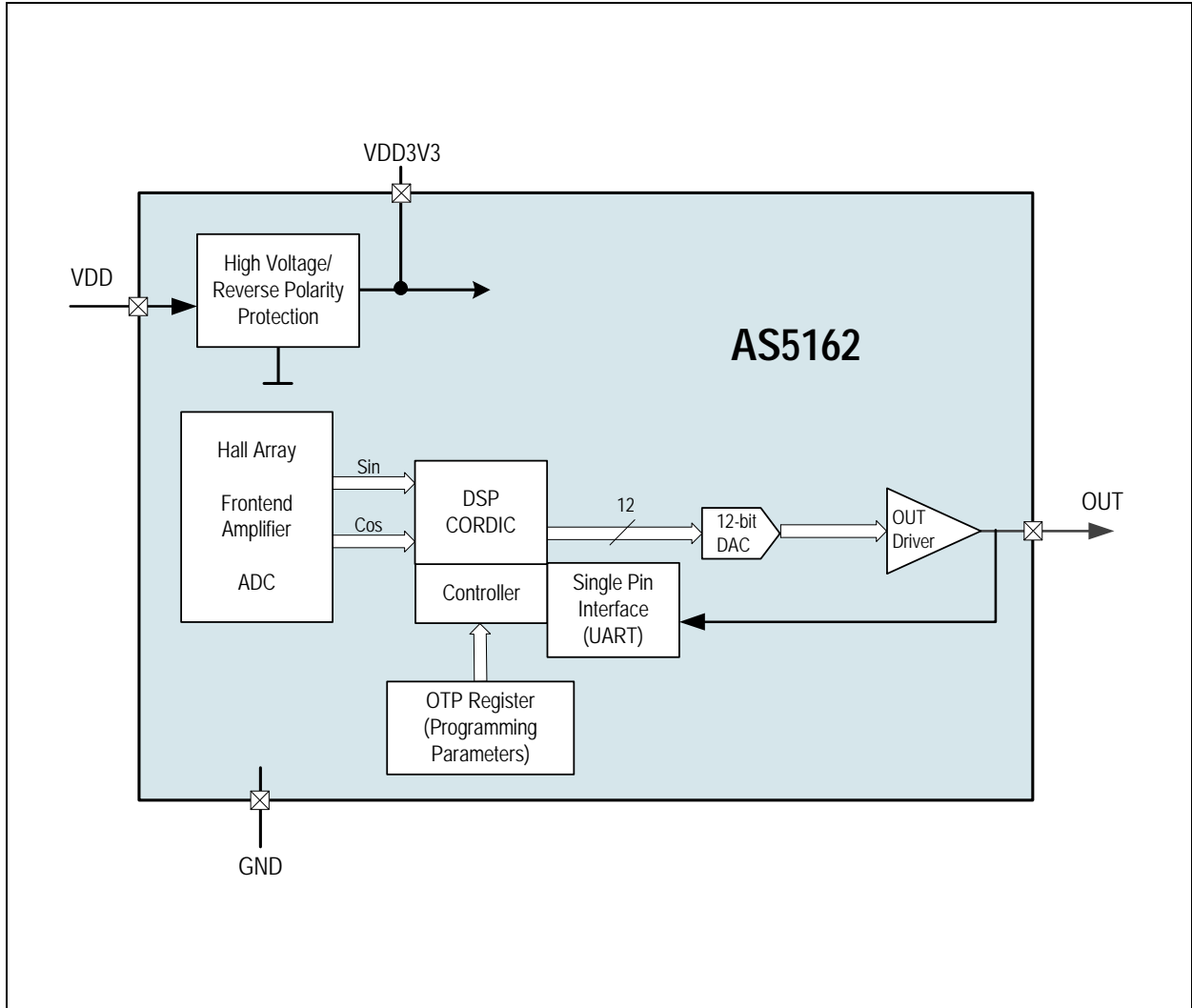
The AS5162 is ideal for automotive applications like:

- Throttle and valve position sensing
- Gearbox position sensor
- Tumble flap
- Chassis height level
- Pedal position sensing
- Contactless potentiometers

Block Diagram

The functional blocks of this device are shown below:

Figure 3:
AS5162 Block Diagram



Pin Assignment

Figure 4:
SOIC-8 Pin Configuration

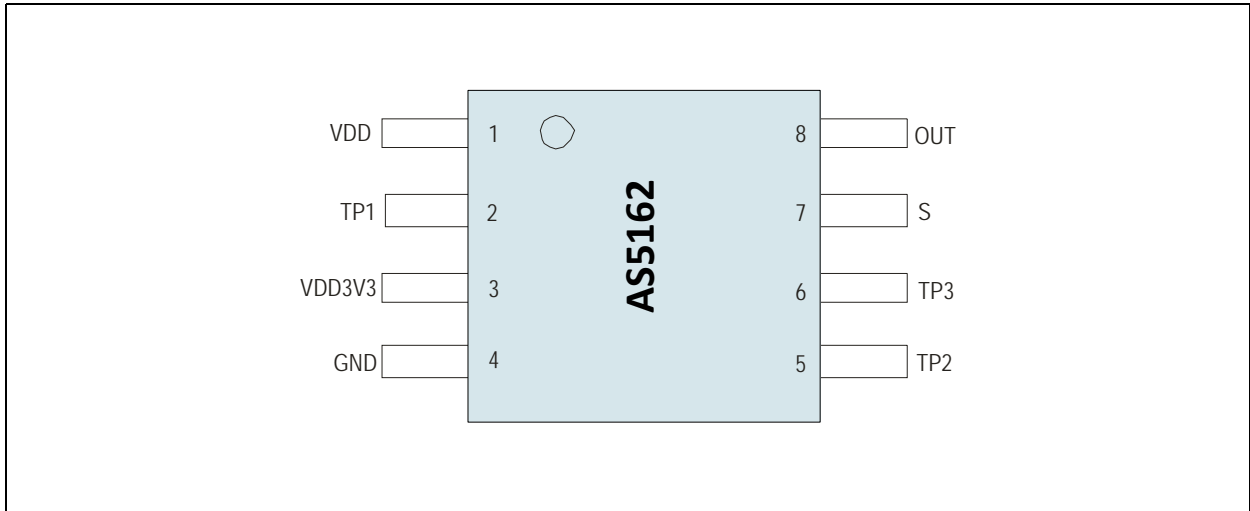


Figure 5:
SOIC-8 Pin Description

| Pin Number | Pin Name | Pin Type | Description |
|------------|----------|---------------------------|--|
| 1 | VDD | Supply pin | Positive supply pin. This pin is over voltage protected. |
| 2 | TP1 | DIO/AIO multi purpose pin | Test pin for fabrication. Connected to ground in the application board. |
| 3 | VDD3V3 | AIO | Output of the internal voltage regulator |
| 4 | GND | Supply pin | Ground pin. Connected to ground in the application. |
| 5 | TP2 | DIO/AIO multi purpose pin | Test pin for fabrication. Connected to ground in the application board. |
| 6 | TP3 | DIO/AIO multi purpose pin | Test pin for fabrication. Open in the application. |
| 7 | S | AIO | Test pin for fabrication. Connected to OUT in the application board. |
| 8 | OUT | DIO/AIO multi purpose pin | Output pin analog output. Over this pin the programming is possible. |

Absolute Maximum Ratings

Stresses beyond those listed in [Absolute Maximum Ratings](#) may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in [Electrical Characteristics](#) is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Figure 6:
Absolute Maximum Ratings

| Symbol | Parameter | Min | Max | Units | Comments |
|--|---|---------|-----|-------|---|
| Electrical Parameters | | | | | |
| V_{DD} | DC supply voltage at pin VDD Overvoltage | -20 | 20 | V | No operation |
| V_{OUT} | Output voltage OUT | -0.3 | 20 | V | Permanent |
| V_{diff} | Voltage difference at pin VDD and OUT | -20 | 20 | V | |
| V_{DD3V3} | DC supply voltage at pin V_{DD3V3} | -0.3 | 5 | V | |
| I_{scr} | Input current (latchup immunity) | -100 | 100 | mA | Norm: AEC-Q100-004 |
| Electrostatic Discharge | | | | | |
| ESD | Electrostatic discharge | ± 2 | | kV | Norm: AEC-Q100-002 |
| Temperature Ranges and Storage Conditions | | | | | |
| T_{strg} | Storage temperature | -55 | 150 | °C | Min -67°F; Max 302°F |
| T_{Body} | Body temperature | | 260 | °C | The reflow peak soldering temperature (body temperature) specified is in accordance with IPC/JEDEC J-STD-020 "Moisture/Reflow Sensitivity Classification for Non-Hermetic Solid State Surface Mount Devices". The lead finish for Pb-free leaded packages is matte tin (100% Sn). |
| RH_{NC} | Relative humidity (non-condensing) | 5 | 85 | % | |
| MSL | Moisture Sensitivity Level | 3 | | | Represents a maximum floor life time of 168h |

Electrical Characteristics

Operating Conditions

In this specification, all the defined tolerances for external components need to be assured over the whole operation conditions range and also over lifetime.

Figure 7:
Operating Conditions

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|------------|---------------------------|------------|-----|-----|-----|-------|
| T_{AMB} | Ambient temperature | | -40 | | 150 | °C |
| I_{supp} | Supply current | | | | 12 | mA |
| V_{DD} | Supply voltage at pin VDD | | 4.5 | 5.0 | 5.5 | V |

Magnetic Input Specification

$T_{AMB} = -40^{\circ}\text{C}$ to 150°C , $V_{DD} = 4.5\text{V}$ to 5.5V (5V operation), unless otherwise noted.

Two-Pole Cylindrical Diametrically Magnetized Source

Figure 8:
Magnetic Input Specification

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-------------|---|--|-----|-----|---------|-------|
| B_{pk} | Magnetic input field amplitude | Required vertical component of the magnetic field strength on the die's surface, measured along a concentric circle with a radius of 1.25 mm | 30 | | 70 | mT |
| B_{pkext} | Magnetic input field amplitude (extended) default setting | Required vertical component of the magnetic field strength on the die's surface, measured along a concentric circle with a radius of 1.25 mm. Increased sensor output noise. | 10 | | 90 | mT |
| B_{off} | Magnetic offset | Constant magnetic stray field | | | ± 5 | mT |
| | Field non-linearity | Including offset gradient | | | 5 | % |
| D_{isp} | Displacement radius | Offset between defined device center and magnet axis. Dependent on the selected magnet. Including Eccentricity. | | 1 | | mm |

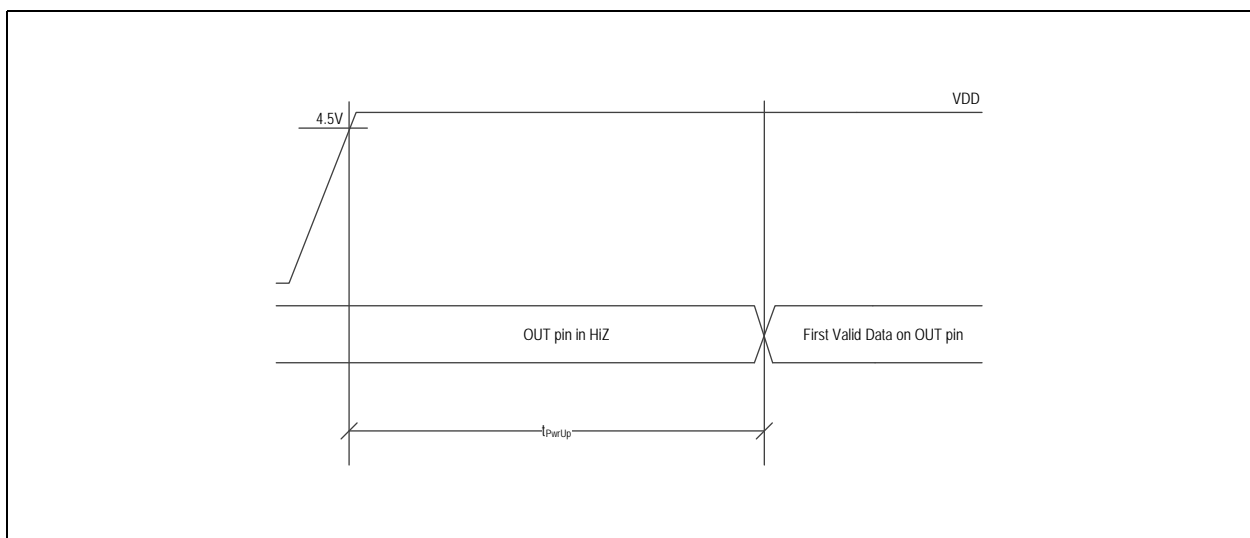
Electrical System Specifications

$T_{AMB} = -40^{\circ}\text{C}$ to 150°C , $V_{DD} = 4.5\text{V}$ to 5.5V (5V operation),
[Magnetic Input Specification](#), unless otherwise noted.

Figure 9:
Electrical System Specifications

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|---------------------|--|--|-----|------|-----|-------|
| RES | Resolution Analog Output | Range > 90° 1LSB=1.221mV typ | | | 12 | bit |
| INL _{opt} | Integral non-linearity (optimum) | Best aligned reference magnet at 25°C over full turn 360°. | | | 0.5 | deg |
| INL _{temp} | Integral non-linearity (optimum) | Best aligned reference magnet over temperature -40° to 150° over full turn 360°. | | | 0.9 | deg |
| INL | Integral non-linearity | Best aligned reference magnet over temperature -40° to 150° over full turn 360° and displacement | | | 1.4 | deg |
| DNL | Differential non-linearity | Monolithic | | 0.05 | | deg |
| ON | Output noise (360° segment) | 1 LSB after filter peak/peak rms value | | 0.2 | | %/VDD |
| t _{PwrUp} | Power-up time 0-5V | See Figure 10 | | | 10 | ms |
| t _{delay} | System propagation delay absolute output: delay of ADC, DSP and absolute interface | 10kOhm, 100 μF RC filter | | | 300 | μs |

Figure 10:
Power-Up Timing Diagram



Timing Characteristics

Figure 11:
Timing Conditions

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-------------|------------------------------|------------|-----|-----|-----|-------|
| T_{DETWD} | WachDog error detection time | | | | 12 | ms |

Power Management - Supply Monitor

Figure 12:
Power Management - Supply Monitor Conditions

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|----------------|--|------------|-----|-----|-----|---------|
| VDD_{UVTH} | VDD undervoltage upper threshold | | 3.5 | 4.0 | 4.5 | V |
| VDD_{UVTL} | VDD undervoltage lower threshold | | 3.0 | 3.5 | 4.0 | V |
| VDD_{UVHYS} | VDD undervoltage hysteresis | | 300 | 500 | 900 | mV |
| VDD_{UVDET} | VDD undervoltage detection time | | 10 | 50 | 250 | μ s |
| VDD_{UVREC} | VDD undervoltage recovery time | | 10 | 50 | 250 | μ s |
| VDD_{OVTH} | VDD overvoltage upper threshold | | 6.0 | 6.5 | 7.0 | V |
| VDD_{OVTL} | VDD overvoltage lower threshold | | 5.5 | 6 | 6.5 | V |
| VDD_{OVHYS} | VDD overvoltage hysteresis | | 300 | 500 | 900 | mV |
| ANA_{TOVDET} | VDD overvoltage detection time (analog path) | | 10 | 50 | 250 | μ s |
| ANA_{TOVREC} | VDD overvoltage recovery time (analog path) | | 10 | 50 | 250 | μ s |

Detailed Description

The AS5162 is manufactured in a CMOS process and uses a spinning current Hall technology for sensing the magnetic field distribution across the surface of the chip.

The integrated Hall elements are placed around the center of the device and deliver a voltage representation of the magnetic field at the surface of the IC.

Through Sigma-Delta Analog / Digital Conversion and Digital Signal-Processing (DSP) algorithms, the AS5162 provides accurate high-resolution absolute angular position information. For this purpose a Coordinate Rotation Digital Computer (CORDIC) calculates the angle and the magnitude of the Hall array signals.

The DSP is also used to provide digital information at the outputs that indicate movements of the used magnet towards or away from the device's surface.

A small low cost diametrically magnetized (two-pole) standard magnet provides the angular position information.

The AS5162 senses the orientation of the magnetic field and calculates a 14-bit binary code. This code is mapped to a programmable output characteristic in analog voltage format. This signal is available at the pin (**OUT**).

The application angular region can be programmed in a user friendly way. The start angle position **T1** and the end point **T2** can be set and programmed according the mechanical range of the application with a resolution of 14 bits. In addition the **T1Y** and **T2Y** parameter can be set and programmed according the application. The transition point 0 to 360 degree can be shifted using the break point parameter **BP**. The voltage for clamping level low **CLL** and clamping level high **CLH** can be programmed with a resolution of 9 bits. Both levels are individually adjustable.

The output parameters can be programmed in an OTP register. No additional voltage is required to program the AS5162. The setting may be overwritten at any time and will be reset to default when power is cycled. To make the setting permanent, the OTP register must be programmed by using a lock bit the content could be frozen for ever.

The AS5162 is tolerant to magnet misalignment and unwanted external magnetic fields due to differential measurement technique and Hall sensor conditioning circuitry.

Operation

VDD Voltage Monitor

VDD Over Voltage Management. If the supply voltage at pin **VDD** exceeds the over-voltage upper threshold for longer than the detection time the output is turned off. When the over-voltage event has passed and the voltage applied to pin **VDD** falls below the over-voltage lower threshold for longer than the recovery time the device enters the normal mode and the output is enabled.

VDD Under Voltage Management. When the voltage applied to the **VDD** pin falls below the under-voltage lower threshold for longer than the detection time the output is turned off. When the voltage applied to the **VDD** pin exceeds the under-voltage upper threshold for longer than the detection time the device enters the normal mode and the output is enabled.

Analog Output

By default (after programmed **CUST_LOCK** OTP bit) the analog output mode is selected. The pin **OUT** provides an analog voltage that is proportional to the angle of the rotating magnet and ratiometric to the supply voltage **VDD**. It can source or sink currents up in normal operation. A short circuit protection is in place and will switch the output driver in high Z in case of an overload event. Due to an intelligent approach a permanent short circuit will not damage the device. This is also feasible in a high voltage condition up to 20 V and at the highest specified ambient temperature.

After the digital signal processing (DSP) a 12-bit Digital-to-Analog converter and output stage provides the output signal.

The DSP maps the application range to the output characteristic. An inversion of the slope is also programmable to allow inversion of the rotation direction.

The reference voltage for the Digital-to-Analog converter (DAC) is taken from **VDD**. In this mode, the output voltage is ratiometric to the supply voltage.

An on-chip diagnostic feature handles the error state at the output. Depending on the failure the output is in HiZ condition or is driven in the failure band (see [Figure 21](#)).

Programming Parameters

The analog output characteristic is programmable by OTP. Depending on the application, the analog output can be adjusted. The user can program the following application specific parameters.

Figure 13:
Programming Parameters

| Parameter | Description |
|-----------|--|
| T1 | Mechanical angle start point |
| T2 | Mechanical angle end point |
| T1Y | Voltage level at the T1 position |
| T2Y | Voltage level at the T2 position |
| CLL | Clamping Level Low |
| CLH | Clamping Level High |
| BP | Break point (transition point 0 to 360°) |

These parameters are input parameters. Using the available programming software and programmer these parameters are converted and finally written into the AS5162 128 bit OTP memory.

Application Specific Angular Range Programming

The application range can be selected by programming **T1** with a related **T1Y** and **T2** with a related **T2Y** into the AS5162. The clamping levels **CLL** and **CLH** can be programmed independent from the **T1** and **T2** position and both levels can be separately adjusted.

Figure 14:
Programming of an Individual Application Range

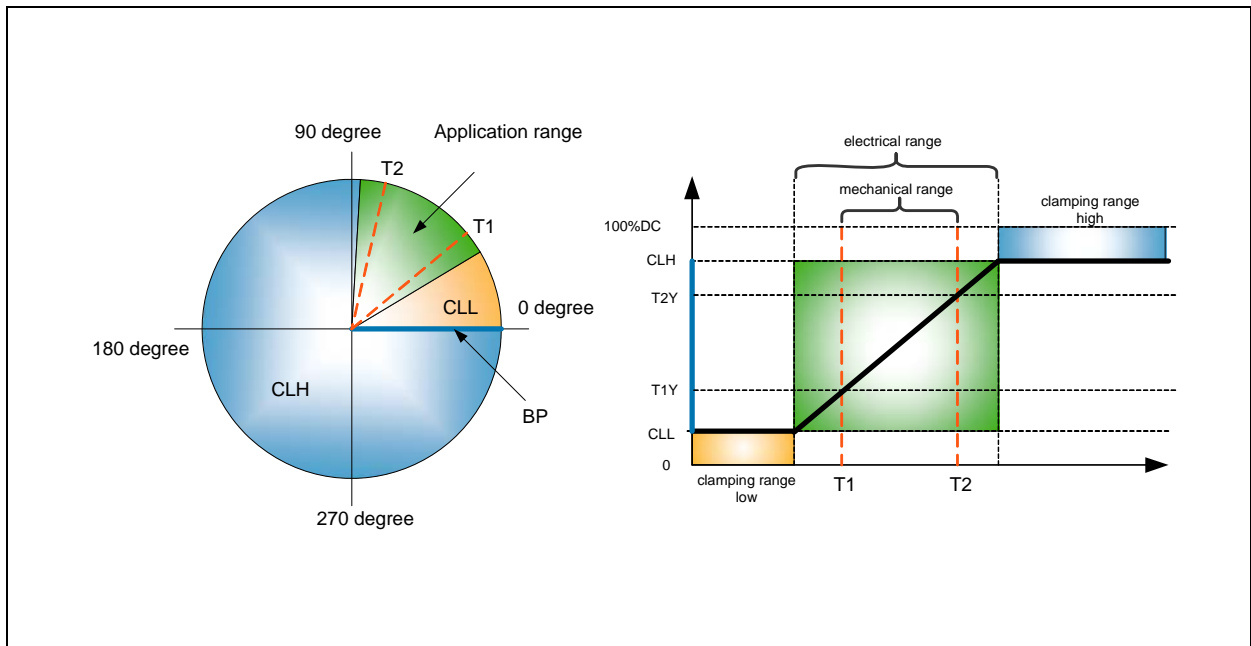
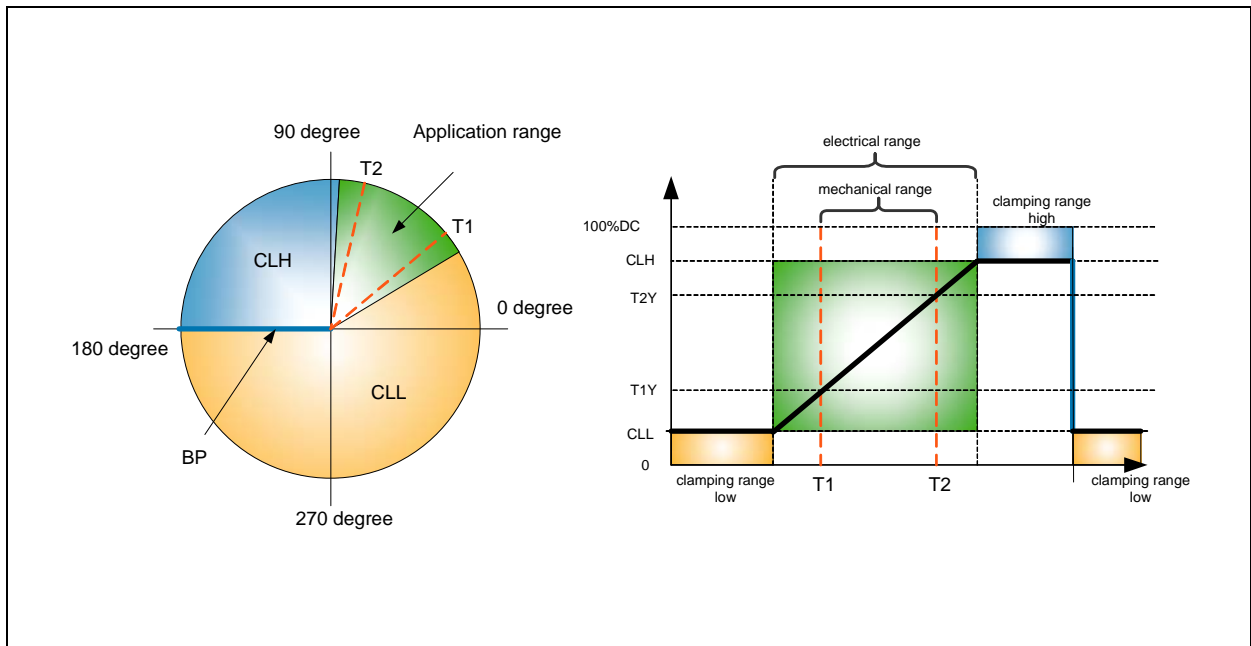


Figure 14 shows a simple example of the selection of the range. The mechanical starting point **T1** and the mechanical end point **T2** are defining the mechanical range. A sub range of the internal CORDIC output range is used and mapped to the needed output characteristic. The analog output signal has 12 bit, hence the level **T1Y** and **T2Y** can be adjusted with this resolution. As a result of this level and the calculated slope the clamping region low is defined. The break point **BP** defines the transition between **CLL** and **CLH**. In this example the **BP** is set to 0 degree. The **BP** is also the end point of the clamping level high **CLH**. This range is defined by the level **CLH** and the calculated slope. Both clamping levels can be set independently from each other.

Application Specific Programming of the Break Point

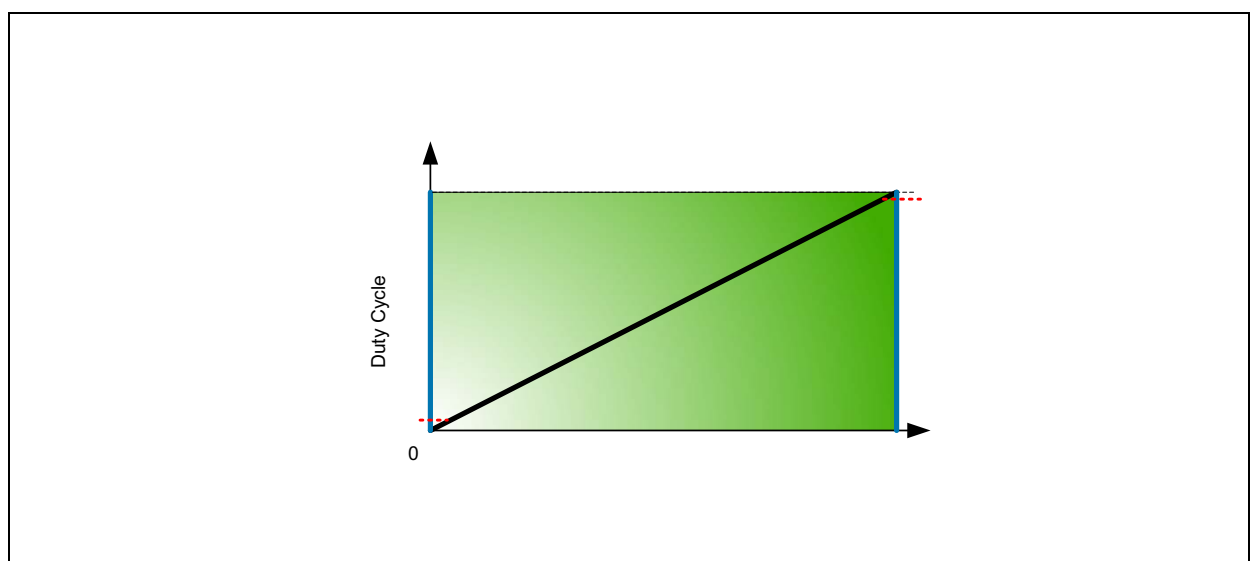
The break point **BP** can be programmed as well with 14 bits. This is important when the default transition point is inside the application range. In such a case the default transition point must be shifted out of the application range. The parameter **BP** defines the new position.

Figure 15:
Individual Programming of the Break Point BP



Full Scale Mode

Figure 16:
Full Scale Mode



For simplification, [Figure 16](#) describes a linear output voltage from rail to rail (0V to VDD) over the complete rotation range. In practice, this is not feasible due to saturation effects of the output stage transistors. The actual curve will be rounded towards the supply rails (as indicated [Figure 16](#)).

Multiple Slope Output

The AS5162 can be programmed to multiple slopes. Where one programmed reference slope characteristic is copied to multiple slopes. Two, three and four slopes are selectable by the user OTP bits QUADEN (1:0). In addition to the steepness of the slope the clamping levels can be programmed as well.

Figure 17:
Two Slope Mode

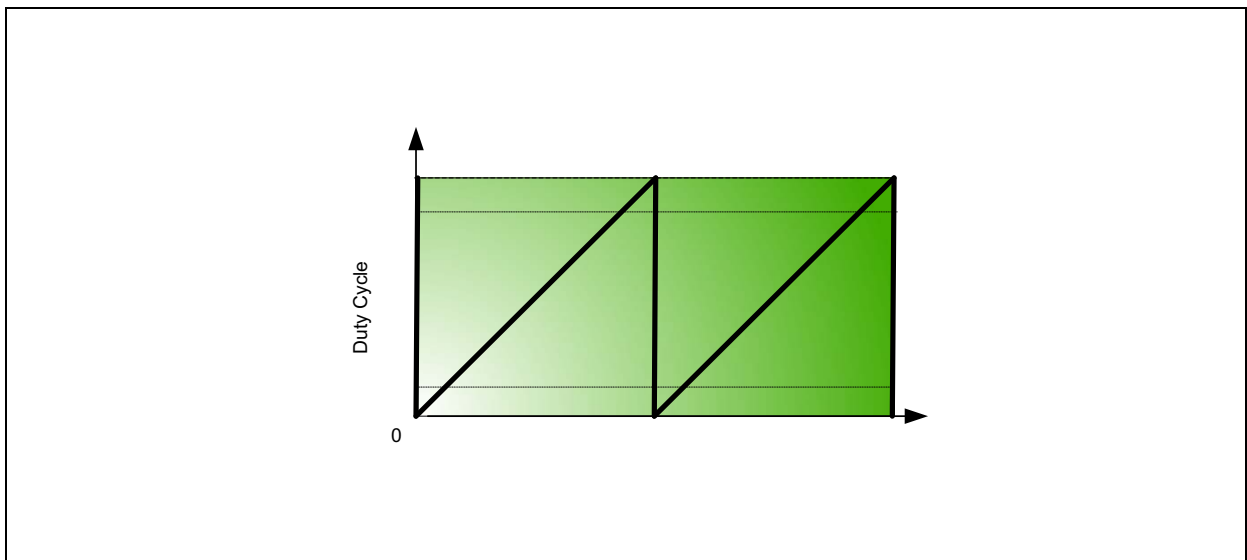
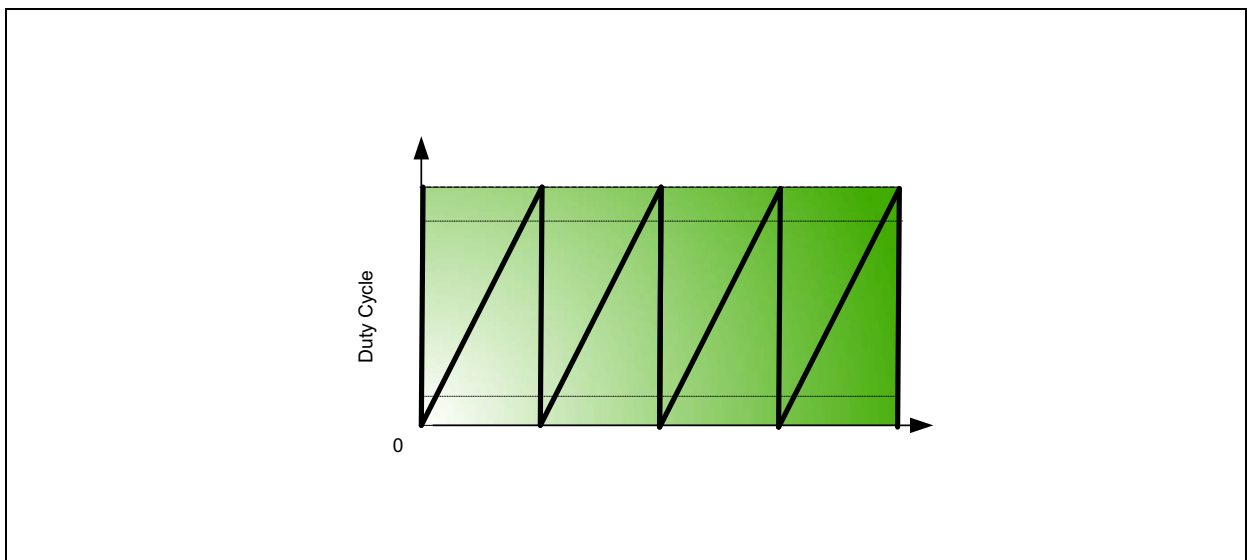


Figure 18:
Four Slope Mode



Resolution of Parameters

The programming parameters have a wide resolution of up to 14 bits.

Figure 19:
Resolution of the Programming Parameters

| Symbol | Parameter | Resolution | Note |
|--------|--------------------------------|------------|------|
| T1 | Mechanical angle start point | 14 bits | |
| T2 | Mechanical angle stop point | 14 bits | |
| T1Y | Mechanical start voltage level | 12 bits | |
| T2Y | Mechanical stop voltage level | 12 bits | |
| CLL | Clamping level low | 9 bits | |
| CLH | Clamping level high | 9 bits | |
| BP | Break point | 14 bits | |

Figure 20:
Overview of the Angular Output Voltage

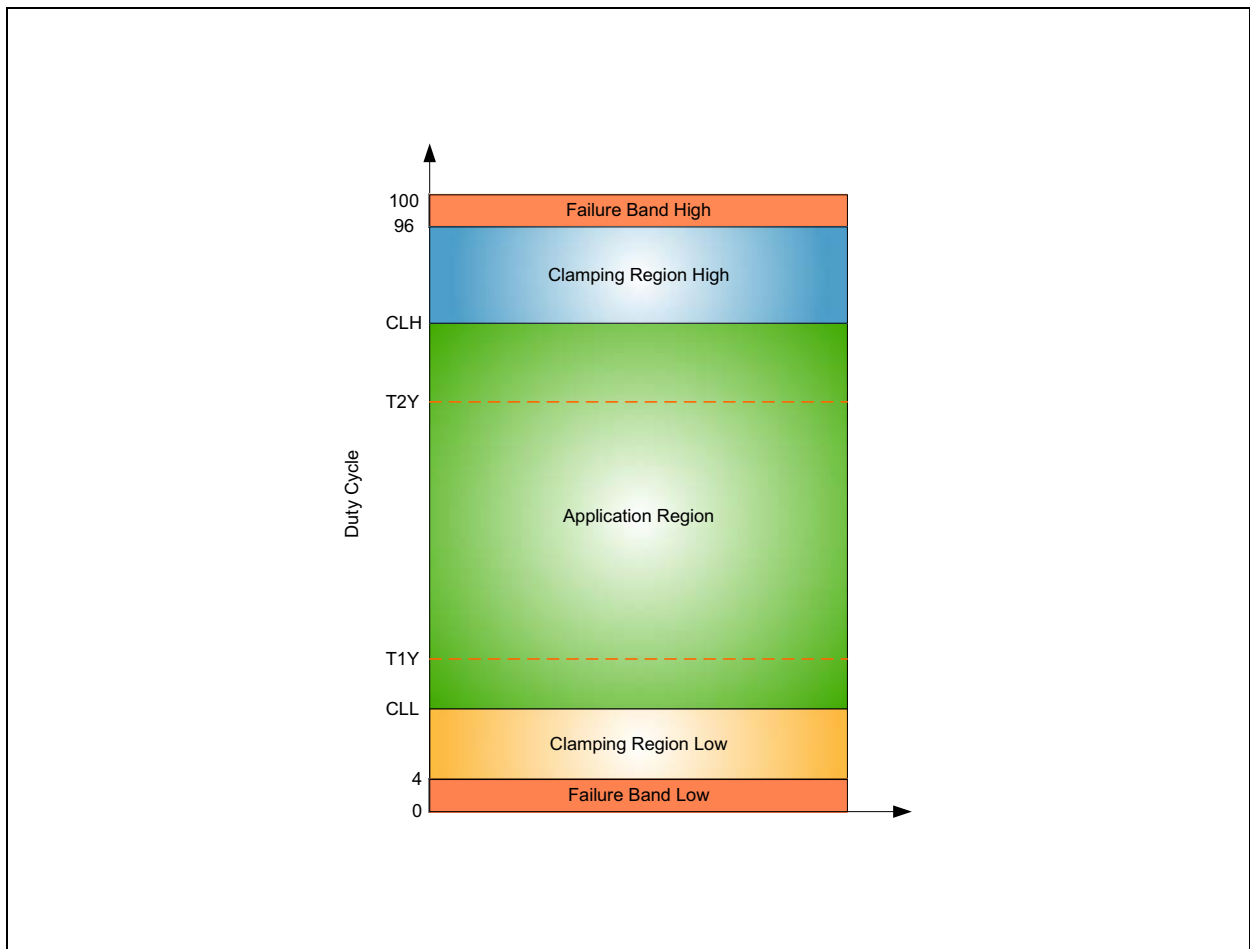


Figure 20 gives an overview of the different ranges. The failure bands are used to indicate a wrong operation of the AS5162. This can be caused due to a broken supply line. By using the specified load resistors, the output level will remain in these bands during a fail. It is recommended to set the clamping level **CLL** above the lower failure band and the clamping level **CLH** below the higher failure band.

Analog Output Diagnostic Mode

Due to the low pin count in the application a wrong operation must be indicated by the output pin **OUT**. This could be realized using the failure bands. The failure band is defined with a fixed level. The failure band low is specified from 0 to 4% of the supply range over the total operation range. The failure band high is defined always from 96 to 100%. Several failures can happen during operation. The output signal remains in these bands over the specified operating and load conditions. All different failures can be grouped into the internal alarms (failures) and the application related failures.

$$C_{LOAD} \leq 33 \text{ nF}, R_{PU} = 4\text{k}\Omega \text{ to } 10\text{k}\Omega$$

$$R_{PD} = 4\text{k}\Omega \text{ to } 10\text{k}\Omega \text{ load pull-up}$$

Figure 21:
Different Failure Cases of AS5162

| Type | Failure Mode | Symbol | Failure Band | Note |
|------------------------------|---|--------|--------------|---|
| Internal alarms (failures) | Out of magnetic range (too less or too high magnetic input) | MAGRng | High/Low | Programmable by OTP bit DIAG_HIGH |
| | CORDIC overflow | COF | High/Low | Programmable by OTP bit DIAG_HIGH |
| | Offset compensation finished | OCF | High/Low | Programmable by OTP bit DIAG_HIGH |
| | Watchdog fail | WDF | High/Low | Programmable by OTP bit DIAG_HIGH |
| | Oscillator fail | OF | High/Low | Programmable by OTP bit DIAG_HIGH |
| Application related failures | Overvoltage condition | OV | High/Low | Dependant on the load resistor Pull up → failure band high Pull down → failure band low |
| | Broken VDD | BVDD | | |
| | Broken VSS | BVSS | | |
| | Short circuit output | SCO | High/Low | Switch off → short circuit dependent |

For efficient use of diagnostics, it is recommended to program to clamping levels **CLL** and **CLH**.

Analog Output Driver Parameters

The output stage is configured in a push-pull output. Therefore it is possible to sink and source currents.

$$C_{LOAD} \leq 33\text{nF}, R_{PU} = 4\text{k}\Omega \text{ to } 10\text{k}\Omega;$$

$$R_{PD} = 4\text{k}\Omega \text{ to } 10\text{k}\Omega \text{ load pull-up}$$

Figure 22:
General Parameters for the Output Driver

| Symbol | Parameter | Min | Typ | Max | Unit | Note |
|----------|---|-------------|-----|------------|---------------|---------------------------|
| IOUTSCL | Short circuit output current (low side driver) | 5 | 10 | 20 | mA | $V_{OUT}=20V$ |
| IOUTSCH | Short circuit output current (high side driver) | -20 | -10 | -5 | mA | $V_{OUT}=0V$ |
| TSCDET | Short circuit detection time | 20 | | 600 | μs | output stage turned off |
| TSCREC | Short circuit recovery time | 2 | | 20 | ms | output stage turned on |
| ILEAKOUT | Output Leakage current | -20 | | 20 | μA | $V_{OUT}=V_{DD}=5V$ |
| BGNDDPU | Output voltage broken GND with pull-up | 96 | | 100 | %VDD | |
| BGNDDPD | Output voltage broken GND with pull-down | 0 | | 4 | %VDD | |
| BVDDPU | Output voltage broken VDD with pull-up | 96 | | 100 | %VDD | |
| BVDDPD | Output voltage broken VDD with pull-down | 0 | | 4 | %VDD | |
| OUTRATIO | Output ratiometric error | -0.5 | | 0.5 | %VDD | |
| OUTDNL | Output DNL | | | $10^{(1)}$ | LSB | Between 4% and 96% of VDD |
| OUTINL | Output INL | $-10^{(2)}$ | | $10^{(2)}$ | LSB | Between 4% and 96% of VDD |

Note(s) and/or Footnote(s):

1. This parameter will be finally defined after temperature characterisation.
2. Design target for this value is reduced.

Hysteresis Function

AS5162 device includes a hysteresis function to avoid sudden jumps from CLH to CLL and vice versa caused by noise in the full turn configuration. The hysteresis amplitude can be selected via the OTP bits **HYSTSEL<1:0>**.

Application Information

Recommended Application Schematic

Figure 23 and Figure 24 show the recommended schematic in the application. All components marked with (*) are optional and can be used to further increase the EMC.

Figure 23:
Recommended Schematic of Pull-Down Configuration

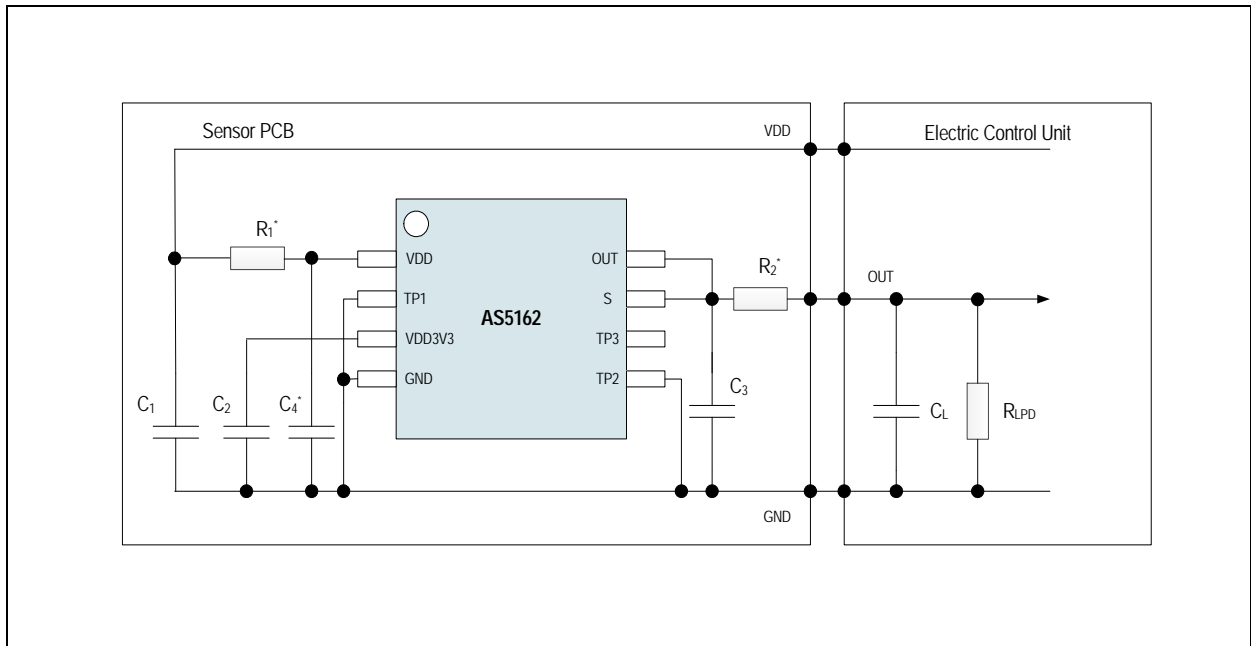


Figure 24:
Recommended Schematic of Pull-Up Configuration

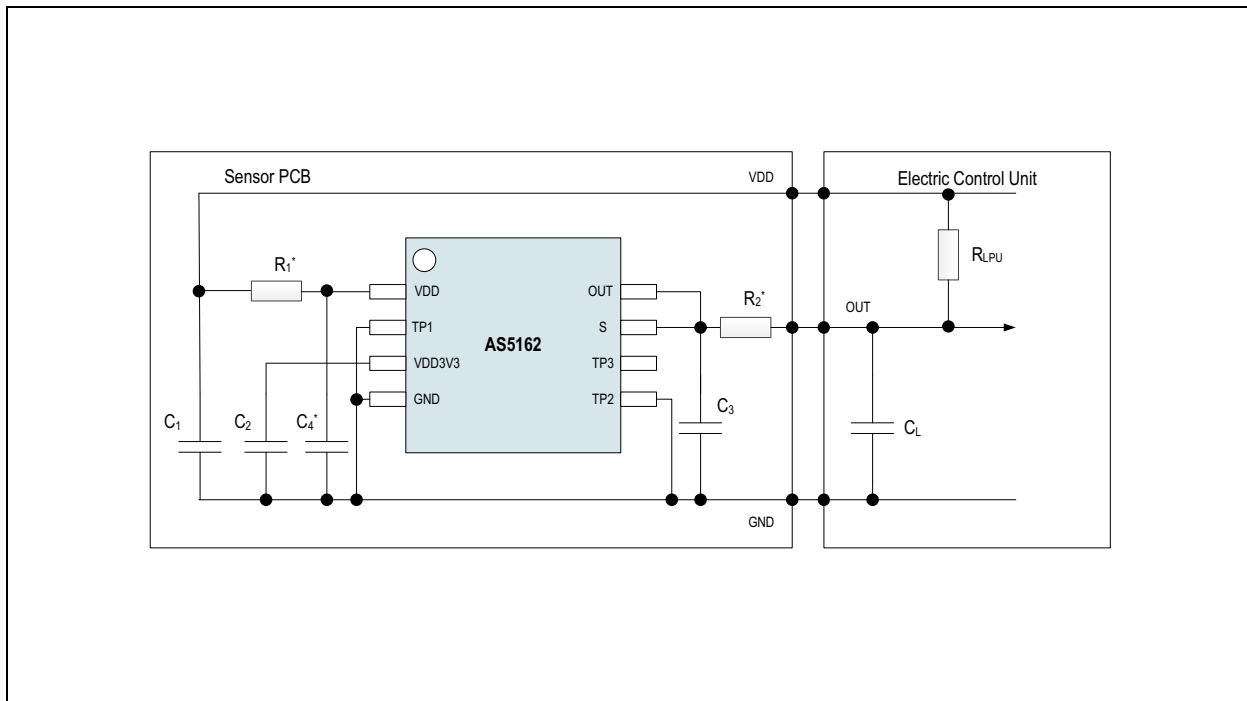


Figure 25:
External Components

| Symbol | Parameter | Min | Typ | Max | Unit | Note |
|-----------|---------------------------------|-----|-----|-----|---------------|--|
| C_1 | VDD buffer capacitor | 0.8 | 1 | 1.2 | μF | Low ESR 0.3 Ω |
| C_2 | VDD3V3 regulator capacitor | 0.8 | 1 | 1.2 | μF | Low ESR 0.3 Ω |
| C_3 | OUT load capacitor (sensor PCB) | 0 | | 4.7 | nF | |
| C_4^* | VDD capacitor (optional) | | 4.7 | | nF | Do not increase due to programming over output |
| R_1^* | VDD serial resistor (optional) | | 10 | | Ω | |
| C_L | OUT load capacitor (ECU) | 0 | | 33 | nF | |
| R_2^* | OUT serial resistor (optional) | | 50 | | Ω | |
| R_{LPU} | OUT pull-up resistance | 4 | | 10 | k Ω | |
| R_{LPD} | OUT pull-down resistance | 4 | | 10 | k Ω | |

Programming the AS5162

The AS5162 programming is a one-time-programming (OTP) method, based on polysilicon fuses. The advantage of this method is that no additional programming voltage is needed. The internal LDO provides the current for programming.

The OTP consists of 128 bits; several bits are available for user programming. In addition factory settings are stored in the OTP memory. Both regions are independently lockable by build in lock bits.

A single OTP cell can be programmed only once. Per default, the cell is "0"; a programmed cell will contain a "1". While it is not possible to reset a programmed bit from "1" to "0", multiple OTP writes are possible, as long as only unprogrammed "0"-bits are programmed to "1".

Independent of the OTP programming, it is possible to overwrite the OTP register temporarily with an OTP write command. This is possible only if the user lock bit is not programmed.

Due to the programming over the output pin the device will initially start in the communication mode. In this mode the digital angle value can be read with a specific protocol format. It is a bidirectional communication possible. Parameters can be written into the device. A programming of the device is triggered by a specific command. With another command (pass2func) the device can be switched into operation mode. In case of a programmed user lock bit the AS5162 automatically starts up in the functional operation mode. No communication of the specific protocol is possible after this.

A standard half duplex UART protocol is used to exchange data with the device in the communication mode.

UART Interface for Programming

The AS5162 uses a standard UART interface with an address byte and two data bytes. The read or write mode is selected with bit R/Wn in the first byte. The timing (baudrate) is selected by the AS5162 over a synchronization frame. The baud rate register can be read and overwritten (optional). Every start bit is used for synchronization.

A time out function detects not complete commands and resets the AS5162 UART after the timeout period.

Frame Organization

Each frame is composed by 24 bits. The first byte of the frame specifies the read/write operation with the register address. 16 data bits contains the communication data. There will be no operation in case of the usage of a not specified CMD. The UART programming interface block of the AS5162 can operate in slave communication or master communication mode. In the slave communication mode the AS5162 receives the data. The programming tool is the driver of the single communication line. In case of the master communication mode the AS5162 transmits data in the frame format. The single communication line can be pulled down by the AS5162.

The UART frame consists of 1 start bit (low level), 8 data bit, 1 even-parity bit and 1 stop bit (high level). Data are transferred from LSB to MSB.

Figure 26:
General UART Frame

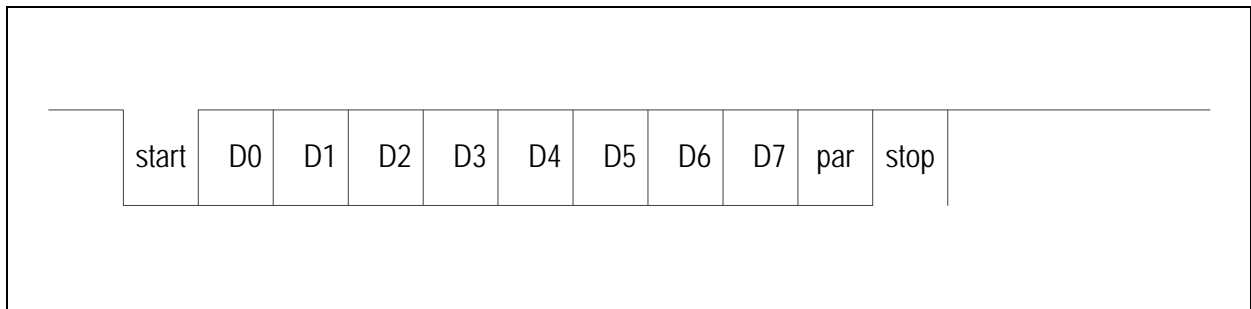


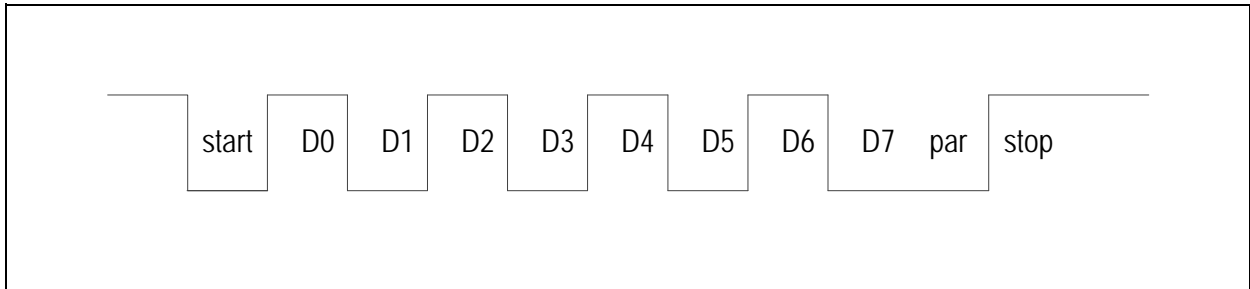
Figure 27:
Bit Timing

| Symbol | Parameter | Min | Typ | Max | Unit | Note |
|--------|--------------------------|-----|-----|-----|------|------|
| START | Start bit | | 1 | | TBIT | |
| Dx | Data bit | | 1 | | TBIT | |
| PAR | Parity bit | | 1 | | TBIT | |
| STOP | Stop bit | 1 | | | TBIT | |
| TSW | Slave/Master Switch Time | | 7 | | TBIT | |

Each communication starts with the reception of a request from the external controller. The request consists of two frames: one synchronization frame and the command frame.

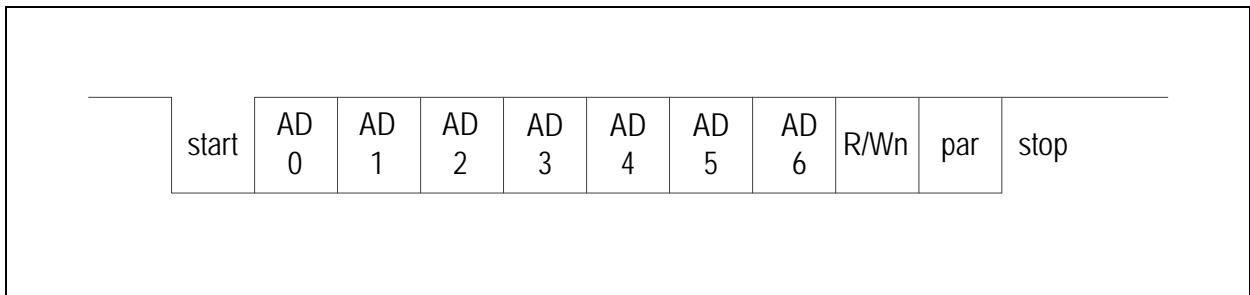
The synchronization frame contains the data 0x55 and allows the UART to measure the external controller baud rate.

Figure 28:
Synchronization Frame



The second frame contains the command Read/ Write (1 bit) and the address (7 bits).

Figure 29:
Address and Command Frame



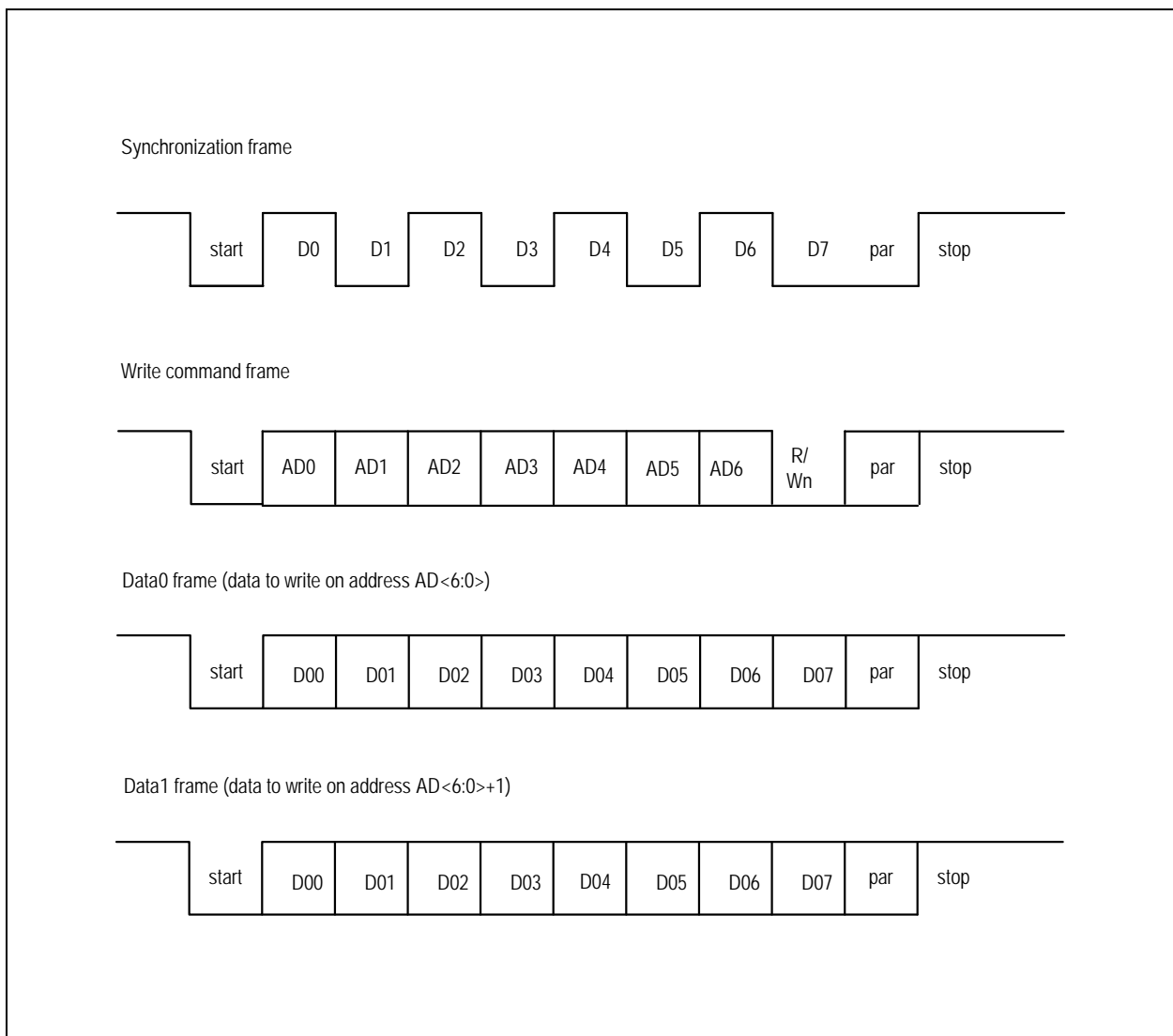
Only two commands are possible. In case of read command the idle phase between the command and the answer is the time TSW. In case of parity error command is not executed.

Figure 30:
Possible Commands

| Possible Interface Commands | Description | AS5X63 Communication Mode | Command CMD |
|-----------------------------|---|---------------------------|-------------|
| WRITE | Write data to the OTP memory or Registers | SLAVE | 0 |
| READ | Read data to the OTP memory or Registers | SLAVE & MASTER | 1 |

Note(s) and/or Footnote(s):

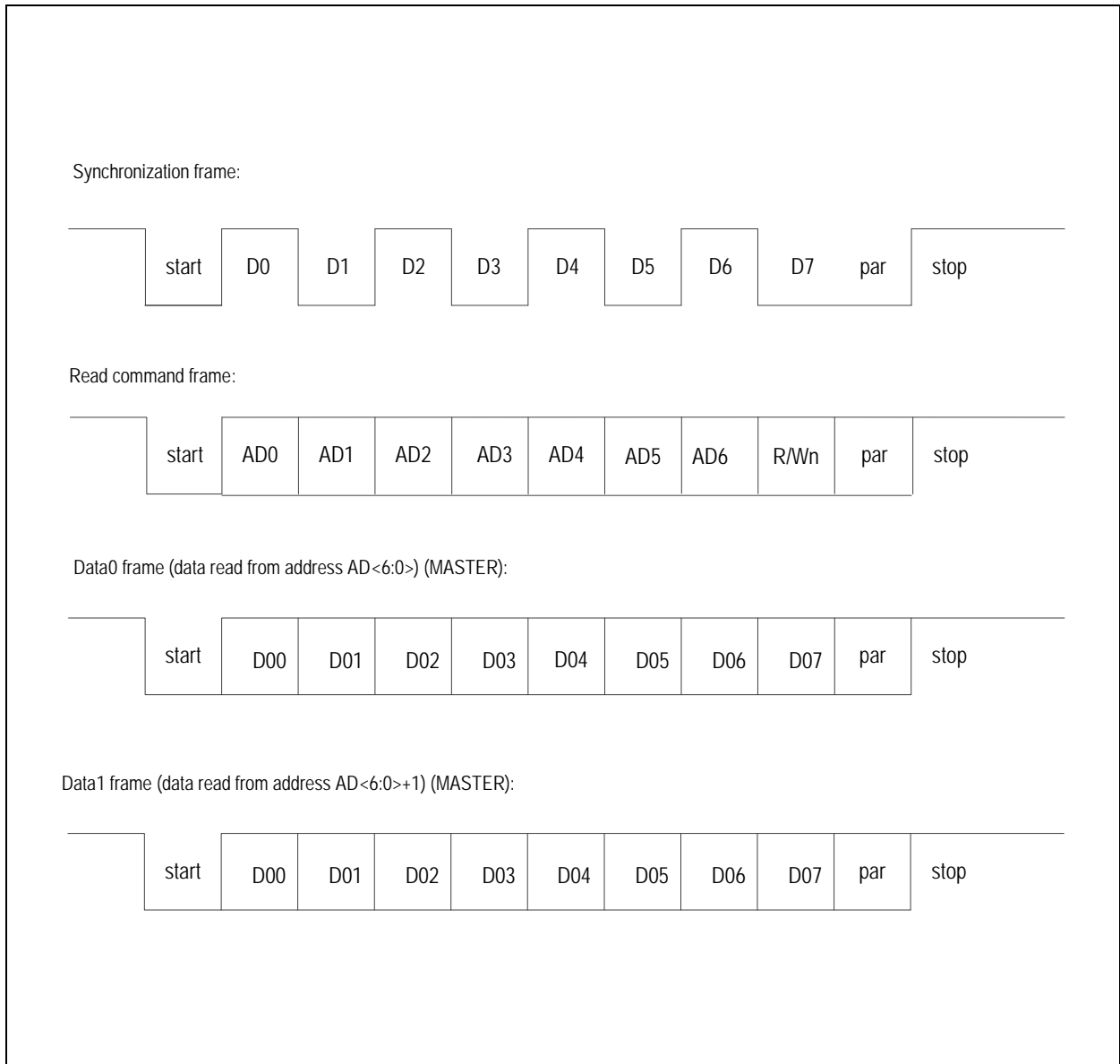
1. In case of Write command the request is followed by the frames containing the data to write.
2. In case of Read command the communication direction will change and the AS5162 will answer with the frames containing the requested data.

WRITE (Command Description)**Figure 31:
Full Write Command**

- Writing the AS5162 KEY in the fuse register (address 0x41) triggers the transfer of the data from the OTP RAM into the Poly Fuse cell.
- Writing the AS5162 KEY in the Pass2Func Register (address 0x60) forces the device into normal mode.

READ (Command Description)

**Figure 32:
Full Read Command**



Baud-Rate Automatic Detection

The UART includes a built-in baud-rate monitor that uses the synchronization frame to detect the external controller baud-rate. This baud-rate is used after the synchronization byte to decode the following frame and to transmit the answer and it is stored in the BAUDREG register.

Baud-Rate Manual Setting (Optional)

The BAUDREG register can be read and over-written for a possible manual setting of the baud-rate: in case the register is overwritten with a value different from 0, this value will be used for the following UART communications and the synchronization frame must be removed from the request.

Figure 33:
Manual Baud-Rate Setting

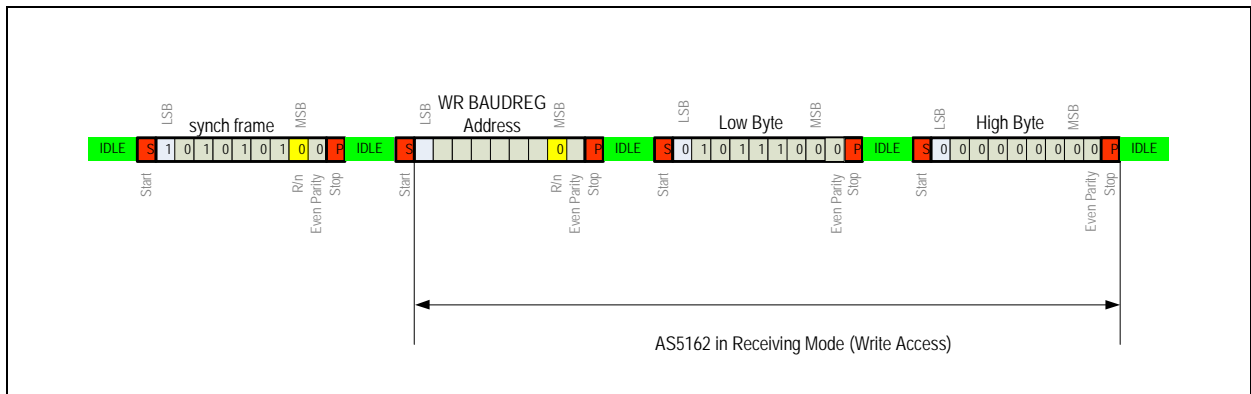
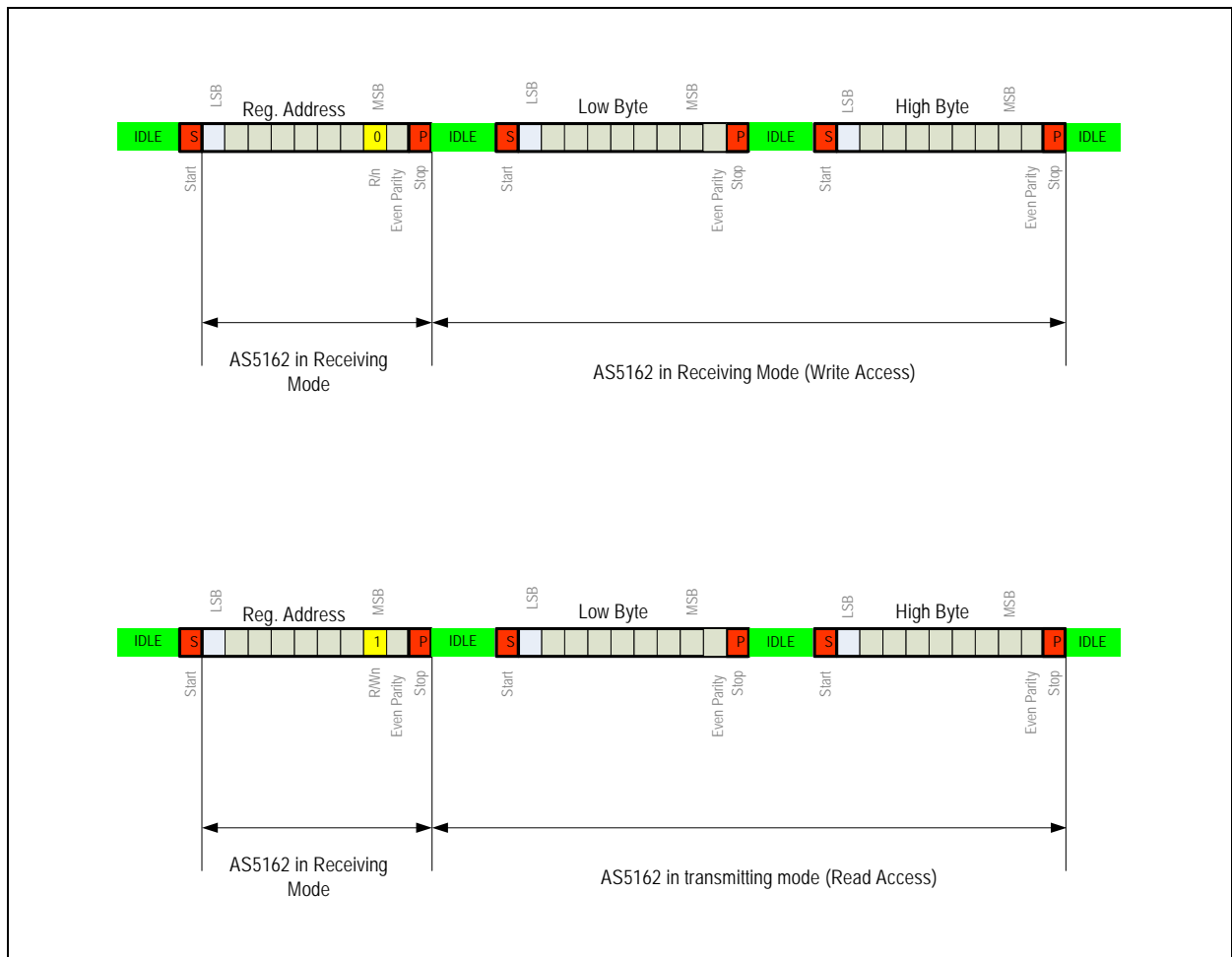


Figure 34:
Simple Read and Write



OTP Programming Data

Figure 35:
OTP Memory Map

| Data Byte | Bit Number | Symbol | Default | Description | |
|---------------|------------|------------------|---------|----------------|------------------|
| DATA15 (0x0F) | 0 | Factory Settings | 0 | ams (reserved) | Factory Settings |
| | 1 | | 0 | | |
| | 2 | | 0 | | |
| | 3 | | 0 | | |
| | 4 | | 0 | | |
| | 5 | | 0 | | |
| | 6 | | 0 | | |
| | 7 | | 0 | | |
| DATA14 (0x0E) | 0 | | 0 | | |
| | 1 | | 0 | | |
| | 2 | | 0 | | |
| | 3 | | 0 | | |
| | 4 | | 0 | | |
| | 5 | | 0 | | |
| | 6 | | 0 | | |
| | 7 | 0 | | | |
| DATA13 (0x0D) | 0 | 0 | | | |
| | 1 | 0 | | | |

| Data Byte | Bit Number | Symbol | Default | Description | |
|---------------|------------|-----------|---------|---------------------|--------------------------|
| DATA13 (0x0D) | 2 | CUSTID<0> | 0 | Customer Identifier | Customer Settings |
| | 3 | CUSTID<1> | 0 | | |
| | 4 | CUSTID<2> | 0 | | |
| | 5 | CUSTID<3> | 0 | | |
| | 6 | CUSTID<4> | 0 | | |
| | 7 | CUSTID<5> | 0 | | |
| DATA12 (0x0C) | 0 | CUSTID<6> | 0 | | |
| DATA11 (0x0B) | 7 | CLH<0> | 0 | Clamping Level High | |
| DATA10 (0x0A) | 0 | CLH<1> | 0 | | |
| | 1 | CLH<2> | 0 | | |
| | 2 | CLH<3> | 0 | | |
| | 3 | CLH<4> | 0 | | |
| | 4 | CLH<5> | 0 | | |
| | 5 | CLH<6> | 0 | | |
| | 6 | CLH<7> | 0 | | |
| | 7 | CLH<8> | 0 | | |

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|-----------|---------|--------------------|--------------------------|
| DATA9 (0x09) | 0 | CLL<0> | 0 | Clamping Level Low | Customer Settings |
| | 1 | CLL<1> | 0 | | |
| | 2 | CLL<2> | 0 | | |
| | 3 | CLL<3> | 0 | | |
| | 4 | CLL<4> | 0 | | |
| | 5 | CLL<5> | 0 | | |
| | 6 | CLL<6> | 0 | | |
| | 7 | CLL<7> | 0 | | |
| DATA8 (0x08) | 0 | CLL<8> | 0 | Offset | |
| | 1 | OFFSET<0> | 0 | | |
| | 2 | OFFSET<1> | 0 | | |
| | 3 | OFFSET<2> | 0 | | |
| | 4 | OFFSET<3> | 0 | | |
| | 5 | OFFSET<4> | 0 | | |
| | 6 | OFFSET<5> | 0 | | |
| | 7 | OFFSET<6> | 0 | | |

| Data Byte | Bit Number | Symbol | Default | Description | | |
|--------------|------------|------------|---------|-------------|--------------------------|--------------|
| DATA7 (0x07) | 0 | OFFSET<7> | 0 | Offset | Customer Settings | |
| | 1 | OFFSET<8> | 0 | | | |
| | 2 | OFFSET<9> | 0 | | | |
| | 3 | OFFSET<10> | 0 | | | |
| | 4 | OFFSET<11> | 0 | | | |
| | 5 | OFFSET<12> | 0 | | | |
| | 6 | OFFSET<13> | 0 | | | |
| | 7 | OFFSET<14> | 0 | | | |
| DATA6 (0x06) | 0 | OFFSET<15> | 0 | | | |
| | 1 | OFFSET<16> | 0 | | | |
| | 2 | OFFSET<17> | 0 | | | |
| | 3 | OFFSET<18> | 0 | | | |
| | 4 | OFFSET<19> | 0 | | | |
| | 5 | GAIN<0> | 0 | | | Scale Factor |
| | 6 | GAIN<1> | 0 | | | |
| | 7 | GAIN<2> | 0 | | | |
| DATA5 (0x05) | 0 | GAIN<3> | 0 | | | |
| | 1 | GAIN<4> | 0 | | | |
| | 2 | GAIN<5> | 0 | | | |
| | 3 | GAIN<6> | 0 | | | |
| | 4 | GAIN<7> | 0 | | | |
| | 5 | GAIN<8> | 0 | | | |
| | 6 | GAIN<9> | 0 | | | |
| | 7 | GAIN<10> | 0 | | | |

| Data Byte | Bit Number | Symbol | Default | Description | |
|---------------|------------|-----------|---------|---|--------------------------|
| DATA4 (0x04) | 0 | GAIN<11> | 0 | Scale Factor | Customer Settings |
| | 1 | GAIN<12> | 0 | | |
| | 2 | GAIN<13> | 0 | | |
| | 3 | GAIN<14> | 0 | | |
| | 4 | GAIN<15> | 0 | | |
| | 5 | GAIN<16> | 0 | | |
| | 6 | BP<0> | 0 | Break Point | |
| 7 | BP<1> | 0 | | | |
| DATA3 (0x003) | 0 | BP<2> | 0 | | |
| | 1 | BP<3> | 0 | | |
| | 2 | BP<4> | 0 | | |
| | 3 | BP<5> | 0 | | |
| | 4 | BP<6> | 0 | | |
| | 5 | BP<7> | 0 | | |
| | 6 | BP<8> | 0 | | |
| DATA2 (0x02) | 7 | BP<9> | 0 | | |
| | 0 | BP<10> | 0 | | |
| | 1 | BP<11> | 0 | | |
| | 2 | BP<12> | 0 | | |
| | 3 | BP<13> | 0 | | |
| | 4 | ANGLERNG | 0 | Sector selection 0=Angular Sector≥22.5 degrees; 1=Angular Sector<22.5 degrees | |
| | 5 | DIAG_HIGH | 0 | Failure Band Selection 0=Failure Band Low 1=Failure Band High | |

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|------------|---------|--|----------------------------|
| DATA2 (0x02) | 6 | QUADEN<0> | 0 | Quadrant Mode Enable 00=1 quadrant; 01=2 quadrants; 10=3 quadrants; 11=4 quadrants | Customer Settings |
| | 7 | QUADEN<1> | 0 | | |
| DATA1 (0x01) | 0 | AIRGAPSEL | 0 | Magnetic input range extension 0:extended range; 1=normal range | |
| | 1 | HYSTSEL<0> | 0 | Hysteresis selection 00=no hysteresis; 01: 56LSB; 10=91LSB; 11=137LSB | |
| | 2 | HYSTSEL<1> | 0 | | |
| | 3 | Not used | 0 | | |
| | 4 | Not used | 0 | | |
| | 5 | Not used | 0 | | |
| | 6 | Not used | 0 | | |
| | 7 | Not used | 0 | | |
| DATA0 (0x00) | 0 | RED_ADD<0> | 0 | Redundancy Address Identify the address of the byte containing the bit to be changed | |
| | 1 | RED_ADD<1> | 0 | | |
| | 2 | RED_ADD<2> | 0 | | |
| | 3 | RED_ADD<3> | 0 | | |
| | 4 | RED_BIT<0> | 0 | Redundancy Bit Identify the position of the bit to be changed in the byte at the address RED_ADD<3:0> | |
| | 5 | RED_BIT<1> | 0 | | |
| | 6 | RED_BIT<2> | 0 | | |
| | 7 | CUST_LOCK | 0 | | Lock bit for Customer Area |

READ / WRITE Register Map

Figure 36:
Read/Write Registers

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|------------|---------|---|------------------------|
| DATA0 (0x20) | 0 | BAUDREG<0> | 0 | UART Baud Rate Register | Read/Write Area |
| | 1 | BAUDREG<1> | 0 | | |
| | 2 | BAUDREG<2> | 0 | | |
| | 3 | BAUDREG<3> | 0 | | |
| | 4 | BAUDREG<4> | 0 | | |
| | 5 | BAUDREG<5> | 0 | | |
| | 6 | BAUDREG<6> | 0 | | |
| | 7 | BAUDREG<7> | 0 | | |
| DATA1 (0x21) | 0 | BAUDREG<8> | 0 | A read command returns all data bits at 0 | |
| | 1 | Not used | 0 | | |
| | 2 | Not used | 0 | | |
| | 3 | Not used | 0 | | |
| | 4 | Not used | 0 | | |
| | 5 | Not used | 0 | | |
| | 6 | Not used | 0 | | |
| | 7 | Not used | 0 | | |

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|-------------|---------|---|------------------------|
| DATA2 (0x22) | 0 | DAC12IN<8> | 0 | DAC12 buffer value | Read/Write Area |
| | 1 | DAC12IN<9> | 0 | | |
| | 2 | DAC12IN<10> | 0 | | |
| | 3 | DAC12IN<11> | 0 | | |
| | 4 | DAC12INSEL | 0 | DAC12 buffer selection | |
| | 5 | R1K10K<0> | 0 | Selection of the reference resistance used for OTP download | |
| | 6 | R1K10K<1> | 0 | | |
| | 7 | DSPRN | 0 | Resetcn of the Digital Signal Processing circuit | |
| DATA3 (0x23) | 0 | DAC12IN<0> | 0 | DAC12 buffer value | |
| | 1 | DAC12IN<1> | 0 | | |
| | 2 | DAC12IN<2> | 0 | | |
| | 3 | DAC12IN<3> | 0 | | |
| | 4 | DAC12IN<4> | 0 | | |
| | 5 | DAC12IN<5> | 0 | | |
| | 6 | DAC12IN<6> | 0 | | |
| | 7 | DAC12IN<7> | 0 | | |

READ Only Register Map

Figure 37:
Read Only Registers

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|----------------|---------|--|------------------|
| DATA0 (0x28) | 0 | Not used | 0 | A read command returns 0 | Read Area |
| | 1 | OFFSETFINISHED | 0 | Offset compensation finished | |
| | 2 | AGCFINISHED | 0 | AGC loop compensation finished | |
| | 3 | CORDICOVF | 0 | Overflow of the CORDIC | |
| | 4 | AGCALARML | 0 | AGC loop saturation because of B field too strong | |
| | 5 | AGCALARMH | 0 | AGC loop saturation because of B field too weak | |
| | 6 | OTP_RES | 0 | 0=1K resistance selected for OTP download; 1=10K resistance selected for OTP download | |
| | 7 | PARITY_ERR | 0 | UART parity error flag | |

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|---------------|---------|---|-----------|
| DATA1 (0x29) | 0 | CORDICOUT<0> | 0 | CORDIC Output | Read Area |
| | 1 | CORDICOUT<1> | 0 | | |
| | 2 | CORDICOUT<2> | 0 | | |
| | 3 | CORDICOUT<3> | 0 | | |
| | 4 | CORDICOUT<4> | 0 | | |
| | 5 | CORDICOUT<5> | 0 | | |
| | 6 | CORDICOUT<6> | 0 | | |
| | 7 | CORDICOUT<7> | 0 | | |
| DATA2 (0x2A) | 0 | CORDICOUT<8> | 0 | | |
| | 1 | CORDICOUT<9> | 0 | | |
| | 2 | CORDICOUT<10> | 0 | | |
| | 3 | CORDICOUT<11> | 0 | | |
| | 4 | CORDICOUT<12> | 0 | | |
| | 5 | CORDICOUT<13> | 0 | | |
| | 6 | Not used | 0 | A read command returns all data bits at 0 | |
| | 7 | Not used | 0 | | |
| DATA3 (0x2B) | 0 | DSPOUT<0> | 0 | DSP Output | |
| | 1 | DSPOUT<1> | 0 | | |
| | 2 | DSPOUT<2> | 0 | | |
| | 3 | DSPOUT<3> | 0 | | |
| | 4 | DSPOUT<4> | 0 | | |
| | 5 | DSPOUT<5> | 0 | | |
| | 6 | DSPOUT<6> | 0 | | |
| | 7 | DSPOUT<7> | 0 | | |

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|-------------|---------|---|------------------|
| DATA4 (0x2C) | 0 | DSPOUT<8> | 0 | DSP Output | Read Area |
| | 1 | DSPOUT<9> | 0 | | |
| | 2 | DSPOUT<10> | 0 | | |
| | 3 | DSPOUT<11> | 0 | | |
| | 4 | Not used | 0 | A read command returns all data bits at 0 | |
| | 5 | Not used | 0 | | |
| | 6 | Not used | 0 | | |
| | 7 | Not used | 0 | | |
| DATA5 (0x2D) | 0 | AGCVALUE<0> | 0 | AGC Value | |
| | 1 | AGCVALUE<1> | 0 | | |
| | 2 | AGCVALUE<2> | 0 | | |
| | 3 | AGCVALUE<3> | 0 | | |
| | 4 | AGCVALUE<4> | 0 | | |
| | 5 | AGCVALUE<5> | 0 | | |
| | 6 | AGCVALUE<6> | 0 | | |
| | 7 | AGCVALUE<7> | 0 | | |
| DATA6 (0x2E) | 0 | MAG<0> | 0 | Magnitude of magnetic field | |
| | 1 | MAG<1> | 0 | | |
| | 2 | MAG<2> | 0 | | |
| | 3 | MAG<3> | 0 | | |
| | 4 | MAG<4> | 0 | | |
| | 5 | MAG<5> | 0 | | |
| | 6 | MAG<6> | 0 | | |
| | 7 | MAG<7> | 0 | | |

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|----------|---------|---|------------------|
| DATA7 (0x2F) | 0 | Not used | 0 | A read command returns all data bits at 0 | Read Area |
| | 1 | Not used | 0 | | |
| | 2 | Not used | 0 | | |
| | 3 | Not used | 0 | | |
| | 4 | Not used | 0 | | |
| | 5 | Not used | 0 | | |
| | 6 | Not used | 0 | | |
| | 7 | Not used | 0 | | |

Special Registers

Figure 38:
Special Registers

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|---------------|---------|---|----------------------|
| DATA0 (0x41) | 0 | AS5162KEY<0> | 0 | AS5162 KEY<15:0>=0101 0001 0110 0010 A write command with data different from AS5162 KEY is not executed A read command returns all data bits at 0 | Fuse Register |
| | 1 | AS5162KEY<1> | 0 | | |
| | 2 | AS5162KEY<2> | 0 | | |
| | 3 | AS5162KEY<3> | 0 | | |
| | 4 | AS5162KEY<4> | 0 | | |
| | 5 | AS5162KEY<5> | 0 | | |
| | 6 | AS5162KEY<6> | 0 | | |
| | 7 | AS5162KEY<7> | 0 | | |
| DATA1 (0x42) | 0 | AS5162KEY<8> | 0 | | |
| | 1 | AS5162KEY<9> | 0 | | |
| | 2 | AS5162KEY<10> | 0 | | |
| | 3 | AS5162KEY<11> | 0 | | |
| | 4 | AS5162KEY<12> | 0 | | |
| | 5 | AS5162KEY<13> | 0 | | |
| | 6 | AS5162KEY<14> | 0 | | |
| | 7 | AS5162KEY<15> | 0 | | |

| Data Byte | Bit Number | Symbol | Default | Description | |
|--------------|------------|---------------|---------|--|---------------------------|
| DATA0 (0x60) | 0 | AS5162KEY<0> | 0 | AS5162 KEY<15:0>=0101 0001 0110 0010 A write command with data different from AS5162 KEY is not executed A read command returns all data bits at 0 | Pass2Func Register |
| | 1 | AS5162KEY<1> | 0 | | |
| | 2 | AS5162KEY<2> | 0 | | |
| | 3 | AS5162KEY<3> | 0 | | |
| | 4 | AS5162KEY<4> | 0 | | |
| | 5 | AS5162KEY<5> | 0 | | |
| | 6 | AS5162KEY<6> | 0 | | |
| | 7 | AS5162KEY<7> | 0 | | |
| DATA1 (0x61) | 0 | AS5162KEY<8> | 0 | | |
| | 1 | AS5162KEY<9> | 0 | | |
| | 2 | AS5162KEY<10> | 0 | | |
| | 3 | AS5162KEY<11> | 0 | | |
| | 4 | AS5162KEY<12> | 0 | | |
| | 5 | AS5162KEY<13> | 0 | | |
| | 6 | AS5162KEY<14> | 0 | | |
| | 7 | AS5162KEY<15> | 0 | | |

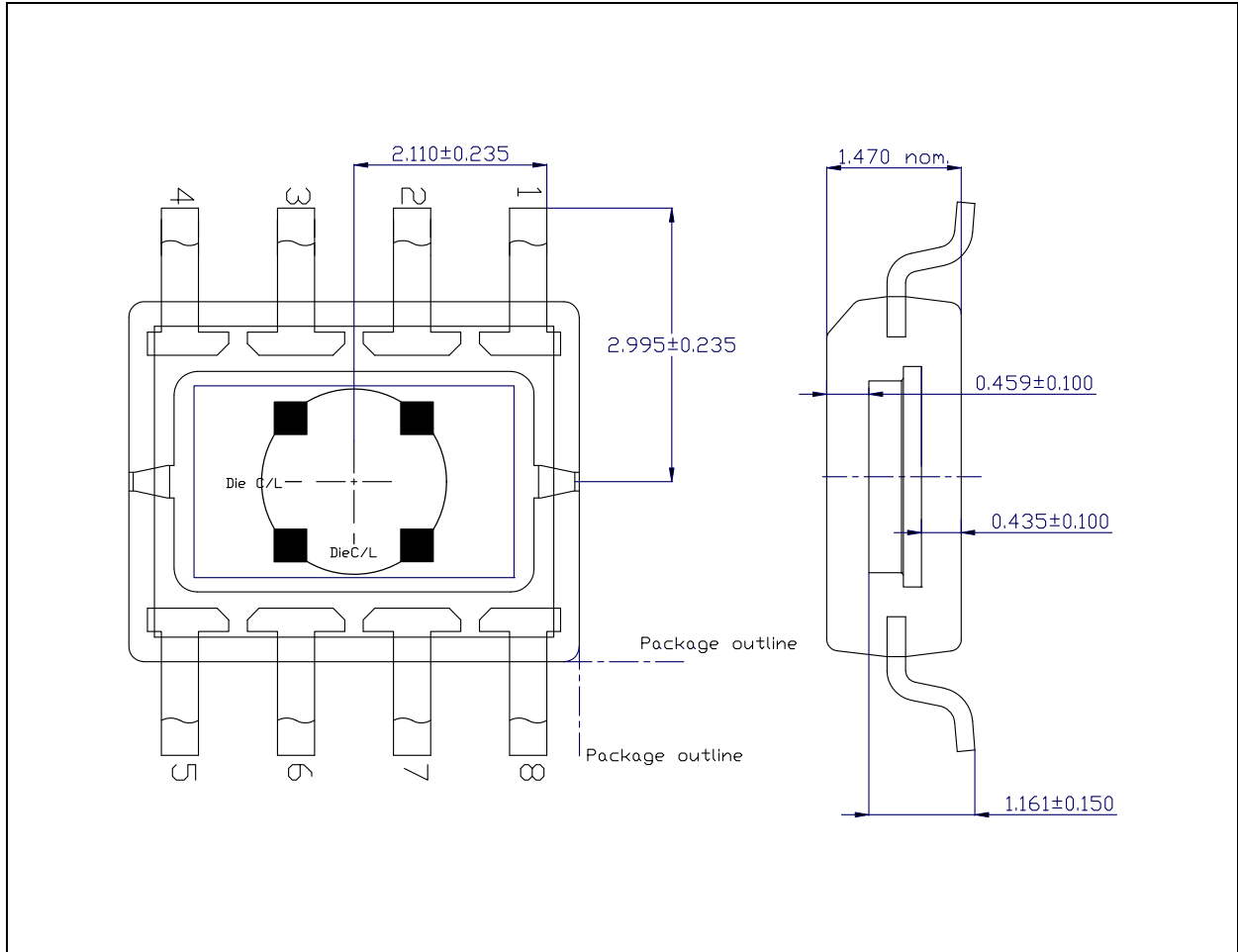
Programming Procedure

- Pull-Up on out pin
- VDD=5V
- Wait 10ms (after the startup time device enters communication mode)
- Write command: Trimming bits are written in the OTP RAM
- Read command: All the trimming bits are read back to check the correctness of the writing procedure.
- Write AS5162KEY in the Fuse register: The OTP RAM content is permanently transferred into the Poly Fuse cells.
- Wait 10 ms (fuse time)
- Write command, R1K_10K<1:0>=(11)b: Poly Fuse cells are downloaded into the RAM memory using a 10K resistance as reference.
- Wait 5 ms (download time)
- Read R1K_10K register, the expected value is 00b
- Write command, R1K_10K<1:0>=(11)b
- Read R1K_10K register, the expected value is (11)b. NB: Step11 and Step12 have to be consecutive.
- Read command: all the fused bits downloaded with 10K resistance are read back.
- Write command, R1K_10K=<1:0>=(10)b: Poly Fuse cells are downloaded into the RAM memory using a 1K resistance as reference.
- Wait 5 ms (download time)
- Read R1K_10K register, the expected value is (00)b
- Write command register, R1K_10K<1:0>=(10)b
- Read R1K_10K register, the expected value is (10)b NB: Step18 and Step19 have to be consecutive.
- Read command: All the fused bits downloaded with 1K resistance are read back.
- Check that read commands at Steps 5, 13 and 19 are matching
- Write AS5162KEY in the Pass2Func register: Device enters normal mode.

Mechanical Data

The internal Hall elements are placed in the center of the package on a circle with a radius of 1.25mm.

Figure 39:
Hall Element Positions

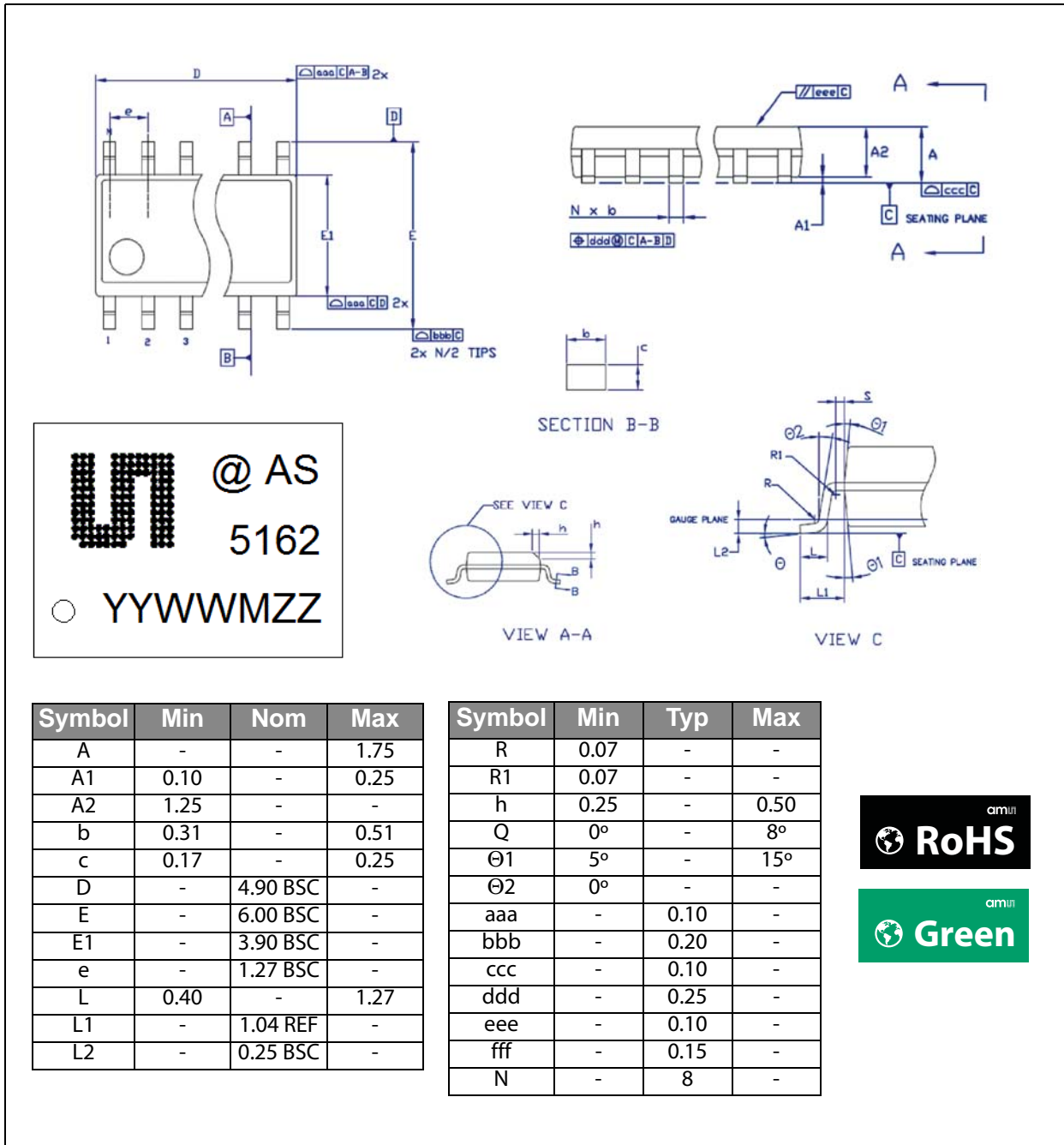


Note(s) and/or Footnote(s):

1. All dimensions in mm.
2. Die thickness $356 \mu\text{m}$ nom.
3. Adhesive thickness $20 \pm 10 \mu\text{m}$.
4. Lead frame downest $200 \pm 25 \mu\text{m}$.
5. Lead frame thickness $200 \pm 8 \mu\text{m}$.

Package Drawings & Markings The device is available in a SOIC 8 - Lead 150 MIL Package.

Figure 40:
Package Drawings and Dimensions



Note(s) and/or Footnote(s):

1. Dimensions and tolerancing confirm to ASME Y14.5M-1994.
2. All dimensions are in millimeters. Angles are in degrees.

Figure 41:
Package Marking: @YYWWMZZ

| @ | YY | WW | M | ZZ |
|-------------------|------|------|---------------------------|----------------------------|
| Sublot identifier | Year | Week | Assembly plant identifier | Assembly traceability code |



Ordering & Contact Information

The devices are available as the standard products shown in [Figure 42](#).

Figure 42:
Ordering Information

| Ordering Code | Description | Package | Delivery Form | Delivery Quantity |
|---------------|--|----------|---------------|-------------------|
| AS5162-HSOP | 12-Bit Programmable Angle Position Sensor with analog output | SOIC - 8 | Tape & Reel | 2500 pcs/reel |
| AS5162-HSOM | | | | 500 pcs/reel |

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Document Status

| Document Status | Product Status | Definition |
|--------------------------|-----------------|--|
| Product Preview | Pre-Development | Information in this datasheet is based on product ideas in the planning phase of development. All specifications are design goals without any warranty and are subject to change without notice |
| Preliminary Datasheet | Pre-Production | Information in this datasheet is based on products in the design, validation or qualification phase of development. The performance and parameters shown in this document are preliminary without any warranty and are subject to change without notice |
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Revision Information

| Changes from 1.3 (2013-Oct-31) to current revision 1-06 (2015-Dec-07) | Page |
|---|------|
| 1.3 (2013-Oct-31) to 1-04 (2015-Aug-07) | |
| Content was updated to the latest ams design | |
| Noise Suppressor section was removed | |
| Updated Key Benefits & Features | 2 |
| Updated Figure 36 | 26 |
| Added Mechanical Data section | 40 |
| Updated Package Drawings & Markings section | 41 |
| Updated Figure 44 | 42 |
| 1-04 (2015-Aug-07) to 1-05 (2015-Nov-19) | |
| Removed Linearization of the Output section | |
| Updated text under Detailed Description | 9 |
| Updated Figure 13 | 11 |
| Updated Figure 19 | 15 |
| 1-05 (2015-Nov-19) to 1-06 (2015-Dec-07) | |
| Updated Figure 2 | 2 |
| Updated Figure 35 [DATA11 (0x0B), DATA12 (0x0C)] | 26 |
| Updated Mechanical Data section | 40 |

Note(s) and/or Footnote(s):

1. Page and figure numbers for the previous version may differ from page and figure numbers in the current revision.
2. Correction of typographical errors is not explicitly mentioned.

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